

Subst. Form PTO-1449 APPLICANT'S INFORMATION DISCLOSURE STATEMENT	Attorney Docket No. 2802-257-088		Serial No.:  101761,941
	Applicant: Michael H. Bunyan, et al		
	Filing Date: Concurrently Herewith	Group: 1742	

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<i>MPG</i>	FZ	Article from July 2002 Semiconductor Magazine entitled Chemical Mechanical Planar by Katherine Derbyshire.
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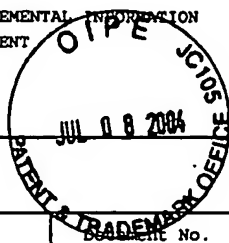
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Filing Date: 01/21/2004		Group: 1755 174Z



## U.S. PATENT DOCUMENTS

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	AR	Copy of Notification of the International Search Report and the Written Opinion of the International Searching Authority, or the Declaration in corresponding International Application No. PCT/US2004/001440
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